AS MUCH AS 26% OFF

MISTAR 555/575 PROMO

MISTAR 555/575 PROMOTION

COORDINATE MEASURING MACHINE

Effective through December 23, 2025



AS MUCH AS 26% OFF MISTAR



Choose from one of the MiSTAR Performance packages, from entry-level quality checks to advanced form analysis and high-volume production—the MiSTAR series delivers reliable, high-performance measurements directly onto the shop floor

MiSTAR Performance Series

BASIC

For first-time CMM users or companies with basic measurement needs

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PROBE SYSTEM: PH6+TP20 - for accuracy in basic measurement, force measuring and module changing options and with the TP20.



MCOSMOS-1: the core module of Mitutoyo's MCOSMOS suite, designed for ease of use, flexibility

- Simple, easy to use MCOSMOS-1.
- 3D-Icon Interface & Ribbon Menus: Ribbons are customizable and support docking so users can tailor the workspace to their needs.
- Quick Access Toolbar: Users can create a personalized quick-access bar for frequently used functions—bypassing ribbon navigation and improving efficiency.

ADVANCED

Adds contact and scanning measurement capabilities powered by CAT1000

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PROBE SYSTEM: PH6M+SP25 – for users requiring a combination of precision scanning with flexible probe configurations.



MCOSMOS-2: the CAD-based programming module enhanced for streamlined measurement routines

- CAT1000: CAD-based program creation with tactile/scanning measuring options, featuring auto path generation and simulation resulting in accurate inspection planning.
- Auto Path Generation (Animated):
 Generates measurement routines directly
 from CAD models, creating animated tool
 paths that both visualize and optimize
 measurement sequences.

ULTIMATE

Adds motorized probe positioning for 2D/3D profile measuring and analysis

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PROBE SYSTEM: PH10MQ+SP25 – for users extended probe positioning with expanded probe options for access and tool changing.



MCOSMOS-3: the complete solution for advanced online/offline CMM programming and part inspection

• Scanpak: Supports profile measurements by capturing continuous scanning input and directly comparing it to nominal CAD data or reference profiles. Provides deviation analysis with clear graphical displays of profile form and surface variation. Ideal for evaluating complex contours and freeform surfaces

Explore the MiSTAR linup here



